# . ..

Test Methodology			Clas	s	
Human Body Model (per JESD22-A114)		3A (Minimum)			
Machine Model (per EIA/JESD22-A115)		A (Minimum)			
Charge Device Model (per JESD22-C101)		IV (Minimum)			
Table 4. Electrical Characteristics         (T <sub>C</sub> = 25°C unless otherwise)	se noted)				
Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 68 Vdc, V <sub>GS</sub> = 0 Vdc)	I <sub>DSS</sub>	_	_	10	μAdc
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc)	I <sub>DSS</sub>	_	_	1	μAdc
Gate - Source Leakage Current (V <sub>GS</sub> = 5 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>			1	μAdc
On Characteristics			•		
Gate Threshold Voltage (V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 250 μAdc)	V <sub>GS(th)</sub>	1	2	3	Vdc
Gate Quiescent Voltage (V <sub>DS</sub> = 28 Vdc, I <sub>D</sub> = 950 mAdc)	V <sub>GS(Q)</sub>	2	2.8	4	Vdc
Drain-Source On-Voltage $(V_{GS} = 10 \text{ Vdc}, I_D = 2.2 \text{ Adc})$	V <sub>DS(on)</sub>	0.1	0.21	0.3	Vdc
Dynamic Characteristics <sup>(1)</sup>	·				
Reverse Transfer Capacitance (V_{DS} = 28 Vdc $\pm$ 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C <sub>rss</sub>	_	1.5		pF

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD}$  = 28 Vdc,  $I_{DQ}$  = 950 mA,  $P_{out}$  = 23 W Avg., f1 = 2112.5 MHz, f2 = 2122.5 MHz and f1 = 2157.5 MHz, f2 = 2167.5 MHz, 2-carrier W-CDMA, 3.84 MHz Channel Bandwidth Carriers, ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset. IM3 measured in 3.84 MHz Channel Bandwidth @ ±10 MHz Offset. PAR = 8.5 dB @ 0.01% Probability on CCDF.

Power Gain	G <sub>ps</sub>	14.5	15.9	17.5	dB
Drain Efficiency	$\eta_D$	26	27.6	—	%
Intermodulation Distortion	IM3	_	-37	-35	dBc
Adjacent Channel Power Ratio	ACPR	_	-39.5	-38	dBc
Input Return Loss	IRL	_	-16	-9	dB

1. Part is internally matched both on input and output.



Figure 1. MRF6S21100HR3(SR3) Test Circuit Schematic

Table 5. MRF6S21100HR3(SR3) 7	Test Circuit Com	ponent Designations	ঃ and Values
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Part	Description	Part Number	Manufacturer
B1	Ferrite Bead	2743019447	Fair-Rite
C1	1.0 μF, 50 V Tantalum Capacitor	T491C105M050AT	Kemet
C2	10 µF, 50 V Electrolytic Capacitor	EEV-HB1H100P	Panasonic
C3	1000 pF 100B Chip Capacitor	ATC100B102JT500XT	ATC
C4, C13	0.1 µF 100B Chip Capacitors	CDR33BX104AKWY	Kemet
C5	5.1 pF Chip Capacitor	ATC100B5R1JT500XT	ATC
C6, C7	15 pF Chip Capacitors	ATC100B150JT500XT	ATC
C8	6.8 pF Chip Capacitors	ATC100B6R8JT500XT	ATC
C9, C10, C11, C12	22 µF, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C14	100 µF, 50 V Electrolytic Capacitor	515D107M050BB6AE3	Vishay/Sprague
R1	1.0 kΩ, 1/8 W Chip Resistor	CRCW08051000FKTA	Vishay
R2	10 Ω, 1/8 W Chip Resistor	CRCW080510R0FKTA	Vishay



Figure 2. MRF6S21100HR3(SR3) Test Circuit Component Layout



Figure 3. 2-Carrier W-CDMA Broadband Performance @ Pout = 23 Watts Avg.



Figure 4. 2-Carrier W-CDMA Broadband Performance @ Pout = 55 Watts Avg.







is operated at V<sub>DD</sub> = 28 Vdc, P<sub>out</sub> = 23 W Avg., and  $\eta_D$  = 27.6%.

MTTF calculator available at http://www.freescale.com/rf. Select Tools/ Software/Application Software/Calculators to access the MTTF calculators by product.

Figure 12. MTTF versus Junction Temperature







Figure 14. 2-Carrier W-CDMA Spectrum





 $V_{DD}$  = 28 Vdc,  $I_{DQ}$  = 950 mA,  $P_{out}$  = 23 W Avg.

f MHz	$Z_{source}$	$Z_{load}_{\Omega}$
2080	2.44 - j6.3	1.83 - j3.0
2110	2.25 - j6.1	1.74 - j2.8
2140	2.09 - j5.8	1.61 - j2.6
2170	1.98 - j5.6	1.59 - j2.5
2200	1.85 - j5.4	1.52 - j2.3

 $Z_{\text{source}}$  = Test circuit impedance as measured from gate to ground.





Figure 15. Series Equivalent Source and Load Impedance



Part	Description	Part Number	Manufacturer
B1	Ferrite Bead	2743019447	Fair-Rite
C1	1.0 µF, 50 V Tantalum Capacitor	T491C105M050AT	Kemet
C2	10 µF, 50 V Electrolytic Capacitor	EEV-HB1H100P	Panasonic
C3	1000 pF 100B Chip Capacitor	ATC100B102JT500XT	ATC
C4, C13	0.1 µF 100B Chip Capacitors	CDR33BX104AKWY	Kemet
C5	5.1 pF Chip Capacitor	ATC100B5R1JT500XT	ATC
C6, C7	15 pF Chip Capacitors	ATC100B150JT500XT	ATC
C8	6.8 pF Chip Capacitors	ATC100B6R8JT500XT	ATC
C9, C10, C11, C12	22 $\mu$ F, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C14	100 µF, 50 V Electrolytic Capacitor	515D107M050BB6AE3	Vishay/Sprague
R1	1.0 kΩ, 1/8 W Chip Resistor	CRCW08051000FKTA	Vishay
R2	10 Ω, 1/8 W Chip Resistor	CRCW080510R0FKTA	Vishay



Figure 17. MRF6S21100HR3(SR3) Test Circuit Component Layout - TD-SCDMA











 $V_{DD} = 28 \text{ Vdc}, I_{DQ} = 800 \text{ mA}$ 

f MHz	$z_{source}$	${\sf Z}_{\sf load}$
1950	1.04 - j4.28	1.38 - j3.90
1960	1.07 - j4.31	1.41 - j3.92
1970	0.96 - j4.13	1.29 - j3.71
1980	0.82 - j3.71	1.12 - j3.34
1990	0.79 - j3.34	1.07 - j2.96
2000	0.82 - j3.15	1.08 - j2.75
2010	0.88 - j3.16	1.12 - j2.76
2020	0.84 - j3.30	1.11 - j2.86
2030	0.83 - j3.47	1.12 - j3.01
2040	0.91 - j3.71	1.22 - j3.20
2050	0.91 - j3.90	1.25 - j3.34
2060	0.81 - j3.81	1.15 - j3.27
2070	0.76 - j3.45	1.09 - j2.92

 $Z_{source} =$  Device input impedance as measured from gate to ground.





Figure 22. Series Equivalent Source and Load Impedance — TD-SCDMA

### PACKAGE DIMENSIONS



# **PRODUCT DOCUMENTATION**

Refer to the following documents to aid your design process.

**Application Notes** 

• AN1955: Thermal Measurement Methodology of RF Power Amplifiers

## **Engineering Bulletins**

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

# **REVISION HISTORY**

The following table summarizes revisions to this document.

Revision	Date	Description
7	Jan. 2007	Added "TD-SCDMA" to data sheet description paragraph, p. 1
		<ul> <li>Removed Lower Thermal Resistance and Low Gold Plating bullets from Features section as functionality is standard, p. 1</li> </ul>
		<ul> <li>Removed Forward Transconductance from On Characteristics table as it no longer provided usable information, p. 2</li> </ul>
		• Updated Part Numbers in Table 5, Component Designations and Values, to RoHS compliant part numbers, p. 3
		<ul> <li>Adjusted scale for Fig. 5, Two-Tone Power Gain versus Output Power, to better match the device's capabilities, p. 5</li> </ul>
		<ul> <li>Removed lower voltage tests from Fig. 11, Power Gain versus Output Power, due to fixed tuned fixture limitations, p. 6</li> </ul>
		<ul> <li>Replaced Fig. 12, MTTF versus Junction Temperature with updated graph. Removed Amps<sup>2</sup> and listed operating characteristics and location of MTTF calculator for device, p. 7</li> </ul>
		<ul> <li>Added TD-SCDMA test circuit schematic, component designations and values, component layout, typical characteristic curves, test signal and series impedance, p. 9-12</li> </ul>
		Added Product Documentation and Revision History, p. 14

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